

Notice of References Cited

Application/Control No.

10/541,611

Applicant(s)/Patent Under
Reexamination
YAMANAKA ET AL.

Examiner

RICHARD Z. ZHU

Art Unit

2625

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,859,712 A	01-1999	Kim, Eun-jin	358/504
*	B	US-5,917,963 A	06-1999	Miyake, Nobutaka	382/300
*	C	US-5,953,465 A	09-1999	Saotome, Shigeru	382/300
*	D	US-6,091,862 A	07-2000	Okisu, Noriyuki	382/300
*	E	US-6,563,538 B1	05-2003	Utagawa, Ken	348/273
*	F	US-6,570,616 B1	05-2003	Chen, Zhe-Hong	348/272
*	G	US-6,704,463 B1	03-2004	Okada et al.	382/300
*	H	US-6,714,242 B1	03-2004	Kobayashi, Atsushi	348/272
*	I	US-7,136,541 B2	11-2006	Zhang et al.	382/300
*	J	US-7,245,326 B2	07-2007	Orlick, Christopher J.	348/448
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.